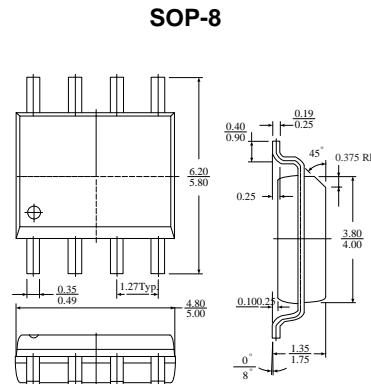


## Description

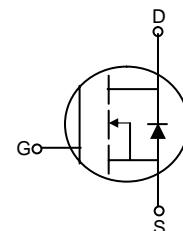
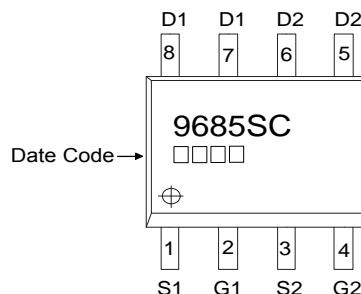
The SSG9685 provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The SOP-8 is universally preferred for all commercial industrial surface mount application and suited for low voltage applications such as DC/DC converters.



## Features

- \* Fast Switching Characteristic
- \* Simple Drive Requirement
- \* Low Gate Charge
- \* RoHS Compliant



## Absolute Maximum Ratings

Parameter	Symbol	Ratings	Unit
Drain-Source Voltage	V <sub>DS</sub>	80	V
Gate-Source Voltage	V <sub>GS</sub>	±20	V
Continuous Drain Current <sup>3</sup>	I <sub>D</sub> @T <sub>A</sub> =25°C	5.3	A
Continuous Drain Current <sup>3</sup>	I <sub>D</sub> @T <sub>A</sub> =70°C	3.4	A
Pulsed Drain Current <sup>1</sup>	I <sub>DM</sub>	50	A
Total Power Dissipation	P <sub>D</sub> @T <sub>A</sub> =25°C	2.5	W
Linear Derating Factor		0.02	W/°C
Operating Junction and Storage Temperature Range	T <sub>j</sub> , T <sub>stg</sub>	-55~+150	°C

## Thermal Data

Parameter	Symbol	Ratings	Unit
Thermal Resistance Junction-ambient <sup>3</sup>	R <sub>thj-a</sub>	50	°C/W



Elektronische Bauelemente

SSG9685

5.3A, 80V, RDS(ON) 45mΩ

N-Channel Enhancement Mode Power Mos.FET

## Electrical Characteristics( Tj=25°C Unless otherwise specified)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Condition
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	80	—	—	V	V <sub>GS</sub> =0V, I <sub>D</sub> =250uA
Breakdown Voltage Temp. Coefficient	△BV <sub>DSS</sub> /△T <sub>j</sub>	—	0.073	—	V/°C	Reference to 25°C, I <sub>D</sub> =1mA
Gate Threshold Voltage	V <sub>GS(th)</sub>	1.0	—	3.0	V	V <sub>DSS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250uA
Gate-Source Leakage Current	I <sub>GSS</sub>	—	—	±100	nA	V <sub>GS</sub> =±20V
Drain-Source Leakage Current (Tj=25°C)	I <sub>DSS</sub>	—	—	1	uA	V <sub>DSS</sub> =80V, V <sub>GS</sub> =0
Drain-Source Leakage Current (Tj=70°C)		—	—	25	uA	V <sub>DSS</sub> =64V, V <sub>GS</sub> =0
Static Drain-Source On-Resistance <sup>2</sup>	R <sub>DSS(ON)</sub>	—	—	45	mΩ	V <sub>GS</sub> =10V, I <sub>D</sub> =5.3A
		—	—	50		V <sub>GS</sub> =4.5V, I <sub>D</sub> =3A
Total Gate Charge <sup>2</sup>	Q <sub>G</sub>	—	19	30	nC	I <sub>D</sub> =5A V <sub>DSS</sub> =64V V <sub>GS</sub> =4.5V
Gate-Source Charge	Q <sub>GS</sub>	—	5	—		
Gate-Drain ("Miller") Charge	Q <sub>GD</sub>	—	10	—		
Turn-on Delay Time <sup>2</sup>	T <sub>d(ON)</sub>	—	11	—	nS	V <sub>DD</sub> =40V I <sub>D</sub> =1A V <sub>GS</sub> =10V R <sub>G</sub> =3.3Ω R <sub>D</sub> =40Ω
Rise Time	T <sub>r</sub>	—	6	—		
Turn-off Delay Time	T <sub>d(OFF)</sub>	—	36	—		
Fall Time	T <sub>f</sub>	—	22	—		
Input Capacitance	C <sub>iss</sub>	—	1710	2730	pF	V <sub>GS</sub> =0V V <sub>DSS</sub> =25V f=1.0MHz
Output Capacitance	C <sub>oss</sub>	—	135	—		
Reverse Transfer Capacitance	C <sub>rss</sub>	—	98	—		
Forward Transconductance	G <sub>fs</sub>	—	9	—	S	V <sub>DSS</sub> =10V, I <sub>D</sub> =5A

## Source-Drain Diode

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Condition
Forward On Voltage <sup>2</sup>	V <sub>DSS</sub>	—	—	1.2	V	I <sub>s</sub> =2A, V <sub>GS</sub> =0V.
Reverse Recovery Time <sup>2</sup>	T <sub>rr</sub>	—	42	—	nS	I <sub>s</sub> =5A, V <sub>GS</sub> =0V.
Reverse Recovery Charge	Q <sub>rr</sub>	—	84	—	nC	dI/dt=100A/us

Notes: 1.Pulse width limited by safe operating area.

2.Pulse width≤300us, dutycycle≤2%.

3.Surface mounted on 1 inch<sup>2</sup> copper pad of FR4 board; 125°C/W when mounted on min. copper pad.

# SECOOS

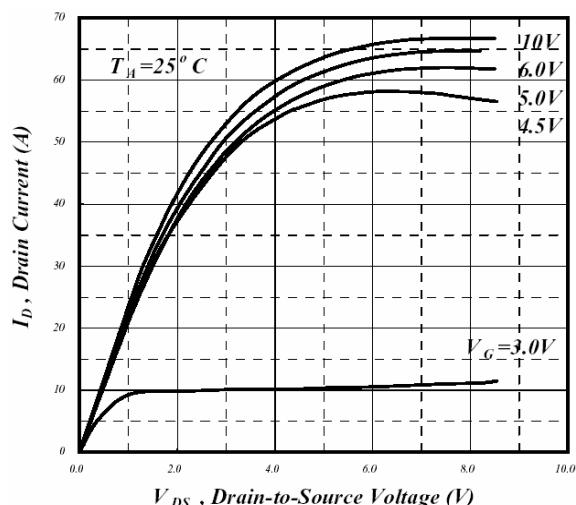
Elektronische Bauelemente

# SSG9685

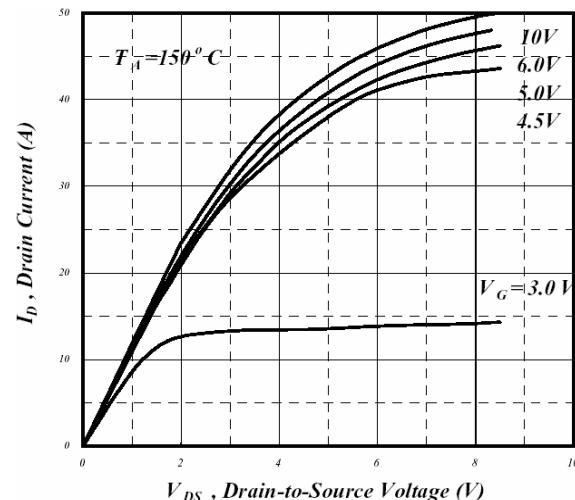
5.3A, 80V, RDS(ON) 45mΩ

N-Channel Enhancement Mode Power Mos.FET

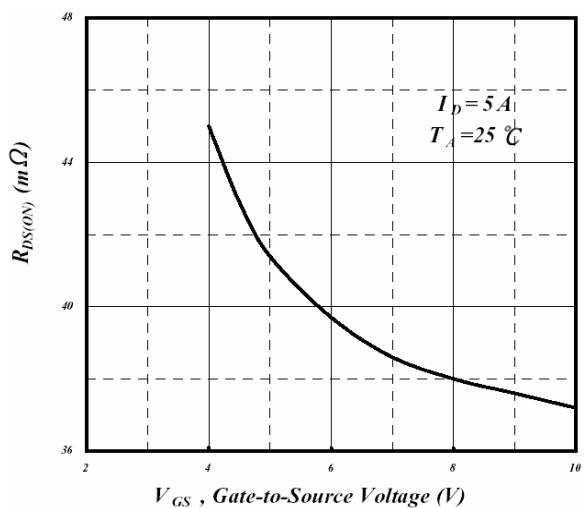
### Characteristics Curve



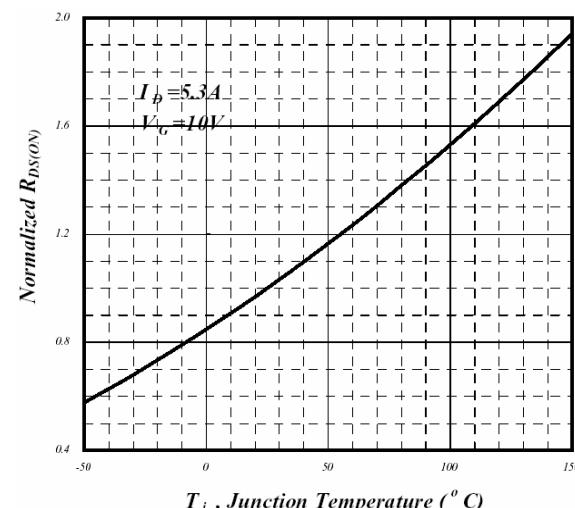
**Fig 1. Typical Output Characteristics**



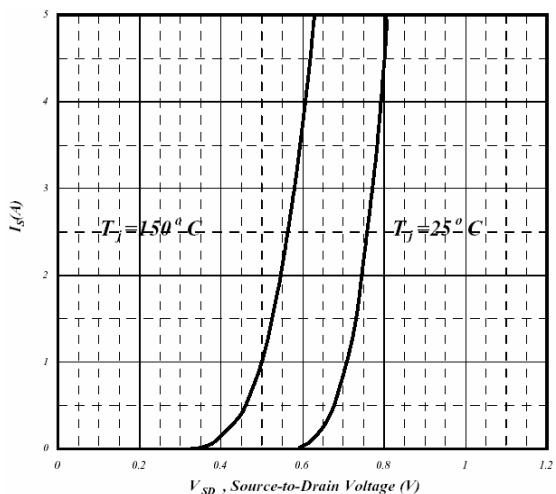
**Fig 2. Typical Output Characteristics**



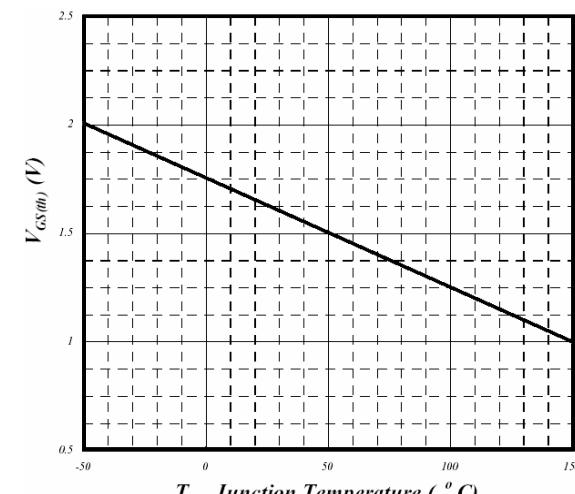
**Fig 3. On-Resistance v.s. Gate Voltage**



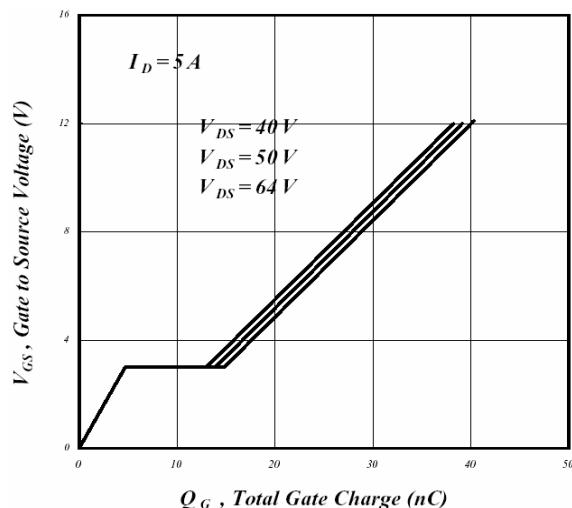
**Fig 4. Normalized On-Resistance v.s. Junction Temperature**



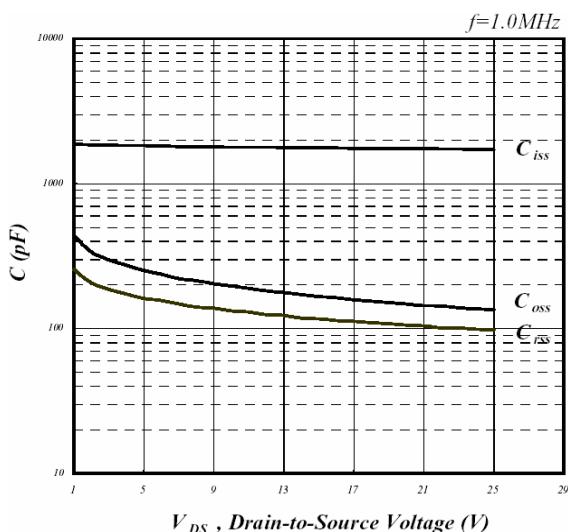
**Fig 5. Forward Characteristics of Reverse Diode**



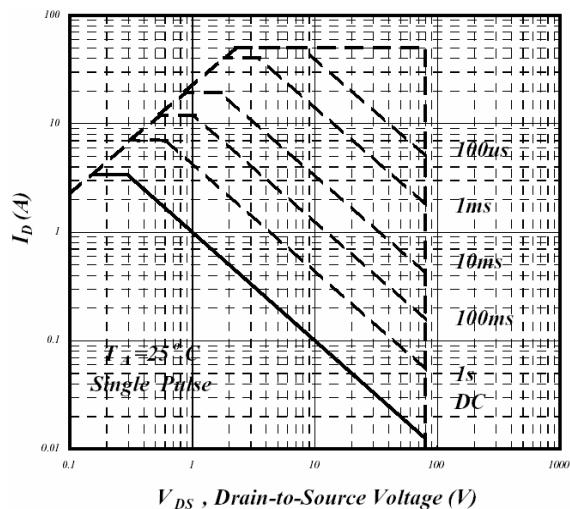
**Fig 6. Gate Threshold Voltage v.s. Junction Temperature**



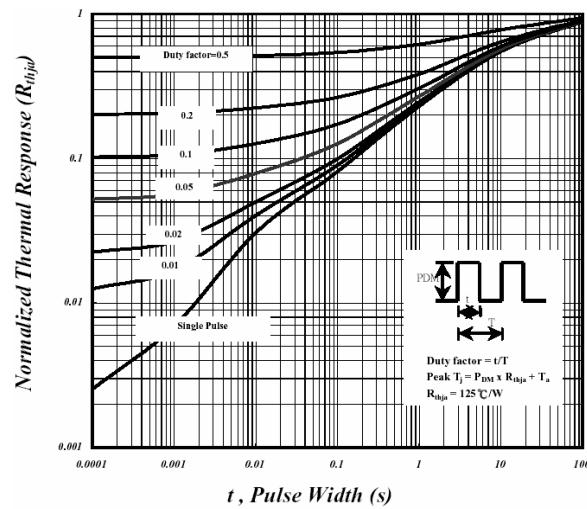
**Fig 7. Gate Charge Characteristics**



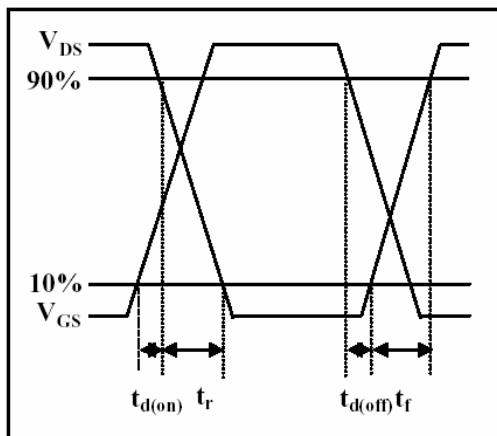
**Fig 8. Typical Capacitance Characteristics**



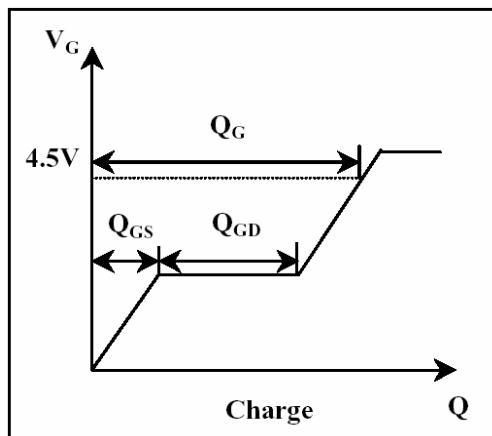
**Fig 9. Maximum Safe Operating Area**



**Fig 10. Effective Transient Thermal Impedance**



**Fig 11. Switching Time Waveform**



**Fig 12. Gate Charge Waveform**